

Electronic supplementary information (ESI) for

Self-assembly and charge carrier transport of solution-processed conjugated polymer monolayers on dielectric surfaces with controlled sub-nanometer roughness

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Table S1 The surface roughness of **S1-S4**.

dielectric	S1	S2	S3	S4
R_{ms} (nm)	0.19±0.01	0.27±0.03	0.30±0.02	0.39±0.04

Table S2 The average (μ_{ave}) and maximum mobilities (μ_{max}) of PCPDTBT monolayers on **S1-S4**. (unit: $\text{cm}^2 \text{V}^{-1} \text{s}^{-1}$)

dielectric	S1	S2	S3	S4
$\mu_{\text{ave}} (\times 10^{-4})$	5.08±0.67	3.65±1.34	3.40±0.59	1.01±0.23
$\mu_{\text{max}} (\times 10^{-4})$	6.42	3.82	3.96	1.18

Table S3 The on/off ratio and threshold voltage of PCPDTBT monolayers on **S1-S4**.

dielectric	S1	S2	S3	S4
$I_{\text{on}}/I_{\text{off}}$	10^3	$10^2 \sim 10^3$	$10^3 \sim 10^4$	$10^2 \sim 10^3$
V_{th} (V)	-20~−15	-5~0	-25~−5	-20~−10

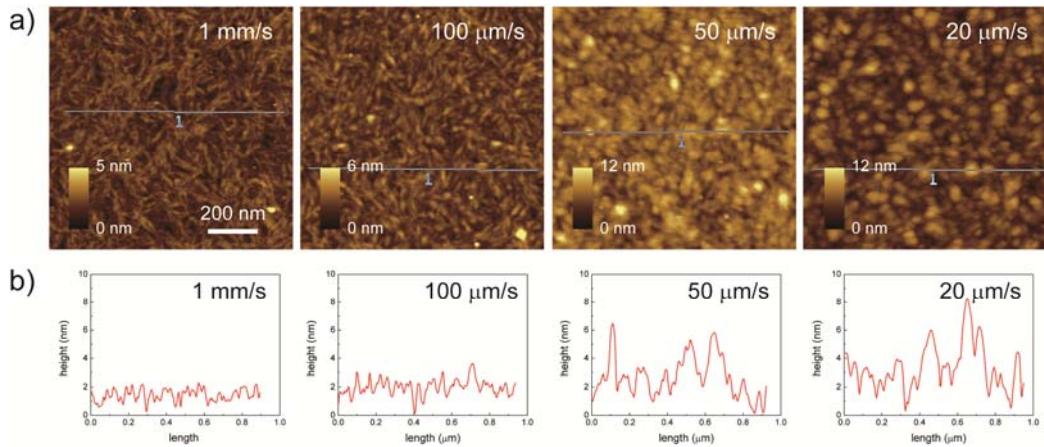


Fig. S1 AFM images (a) and corresponding height plots (b) of PCPDTBT thin films deposited on bare SiO₂ substrate at various dip-coating speeds. The maximum heights coincide with one, two, three and four polymer layers for 1 mm/s, 100 μm/s, 50 μm/s and 20 μm/s, respectively.